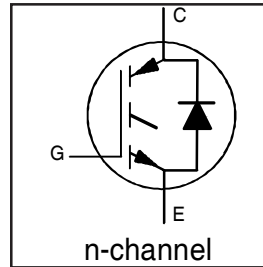


IRG4BC20SD-SPbF

INSULATED GATE BIPOLAR TRANSISTOR WITH ULTRAFAST SOFT RECOVERY DIODE Standard Speed IGBT

Features

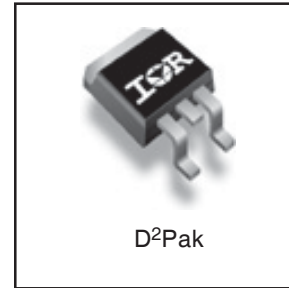
- Extremely low voltage drop 1.4Vtyp. @ 10A
- S-Series: Minimizes power dissipation at up to 3 KHz PWM frequency in inverter drives, up to 4 KHz in brushless DC drives.
- Very Tight Vce(on) distribution
- IGBT co-packaged with HEXFRED™ ultrafast, ultra-soft-recovery anti-parallel diodes for use in bridge configurations
- Industry standard D²Pak package
- Lead-Free



| |
|-----------------------------|
| $V_{CES} = 600V$ |
| $V_{CE(on) typ.} = 1.4V$ |
| @ $V_{GE} = 15V, I_C = 10A$ |

Benefits

- Generation 4 IGBT's offer highest efficiencies available
- IGBT's optimized for specific application conditions
- HEXFRED diodes optimized for performance with IGBT's . Minimized recovery characteristics require less/no snubbing
- Lower losses than MOSFET's conduction and Diode losses



Absolute Maximum Ratings

| | Parameter | Max. | Units |
|---------------------------|----------------------------------|-------------|------------|
| V_{CES} | Collector-to-Emitter Voltage | 600 | V |
| $I_C @ T_C = 25^\circ C$ | Continuous Collector Current | 19 | A |
| $I_C @ T_C = 100^\circ C$ | Continuous Collector Current | 10 | |
| I_{CM} | Pulsed Collector Current ① | 38 | |
| I_{LM} | Clamped Inductive Load Current ② | 38 | |
| $I_F @ T_C = 100^\circ C$ | Diode Continuous Forward Current | 7.0 | |
| I_{FM} | Diode Maximum Forward Current | 38 | V |
| V_{GE} | Gate-to-Emitter Voltage | ± 20 | |
| $P_D @ T_C = 25^\circ C$ | Maximum Power Dissipation | 60 | W |
| $P_D @ T_C = 100^\circ C$ | Maximum Power Dissipation | 24 | |
| T_J | Operating Junction and | -55 to +150 | $^\circ C$ |
| T_{STG} | Storage Temperature Range | | |

Thermal Resistance

| | Parameter | Typ. | Max. | Units |
|-----------------|---|------|------|--------------|
| $R_{\theta JC}$ | Junction-to-Case - IGBT | — | 2.1 | $^\circ C/W$ |
| $R_{\theta JC}$ | Junction-to-Case - Diode | — | 3.5 | |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB Mounted, steady-state)* | — | 80 | |
| Wt | Weight | 1.44 | — | g (oz) |

* When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.

IRG4BC20SD-SPbF

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|--|---|------|------|------|-------|--|
| V _{(BR)CES} | Collector-to-Emitter Breakdown Voltage _f | 600 | — | — | V | V _{GE} = 0V, I _C = 250μA |
| ΔV _{(BR)CES} /ΔT _J | Temperature Coeff. of Breakdown Voltage | — | 0.75 | — | V/°C | V _{GE} = 0V, I _C = 1.0mA |
| V _{CE(on)} | Collector-to-Emitter Saturation Voltage | — | 1.40 | 1.6 | V | I _C = 10A I _C = 19A I _C = 10A, T _J = 150°C |
| | | — | 1.85 | — | | |
| | | — | 1.44 | — | | |
| V _{GE(th)} | Gate Threshold Voltage | 3.0 | — | 6.0 | | V _{CE} = V _{GE} , I _C = 250μA |
| ΔV _{GE(th)} /ΔT _J | Temperature Coeff. of Threshold Voltage | — | -11 | — | mV/°C | V _{CE} = V _{GE} , I _C = 250μA |
| g _{fe} | Forward Transconductance [Ⓢ] | 2.0 | 5.8 | — | S | V _{CE} = 100V, I _C = 10A |
| I _{CES} | Zero Gate Voltage Collector Current | — | — | 250 | μA | V _{GE} = 0V, V _{CE} = 600V V _{GE} = 0V, V _{CE} = 600V, T _J = 150°C |
| | | — | — | 1700 | | |
| V _{FM} | Diode Forward Voltage Drop | — | 1.4 | 1.7 | V | I _C = 8.0A I _C = 8.0A, T _J = 150°C |
| | | — | 1.3 | 1.6 | | |
| I _{GES} | Gate-to-Emitter Leakage Current | — | — | ±100 | nA | V _{GE} = ±20V |

Switching Characteristics @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|--------------------------|---|------|------|------|-------|--|
| Q _g | Total Gate Charge (turn-on) | — | 27 | 40 | nC | I _C = 10A V _{CC} = 400V V _{GE} = 15V See Fig. 8 |
| Q _{ge} | Gate - Emitter Charge (turn-on) | — | 4.3 | 6.5 | | |
| Q _{gc} | Gate - Collector Charge (turn-on) | — | 10 | 15 | | |
| t _{d(on)} | Turn-On Delay Time | — | 62 | — | ns | T _J = 25°C I _C = 10A, V _{CC} = 480V V _{GE} = 15V, R _G = 50Ω Energy losses include "tail" and diode reverse recovery. See Fig. 9, 10, 11, 18 |
| t _r | Rise Time | — | 32 | — | | |
| t _{d(off)} | Turn-Off Delay Time | — | 690 | 1040 | | |
| t _f | Fall Time | — | 480 | 730 | | |
| E _{on} | Turn-On Switching Loss | — | 0.32 | — | mJ | T _J = 150°C, See Fig. 10, 11, 18 I _C = 10A, V _{CC} = 480V V _{GE} = 15V, R _G = 50Ω Energy losses include "tail" and diode reverse recovery. |
| E _{off} | Turn-Off Switching Loss | — | 2.58 | — | | |
| E _{ts} | Total Switching Loss | — | 2.90 | 4.5 | | |
| t _{d(on)} | Turn-On Delay Time | — | 64 | — | ns | Measured 5mm from package |
| t _r | Rise Time | — | 35 | — | | |
| t _{d(off)} | Turn-Off Delay Time | — | 980 | — | | |
| t _f | Fall Time | — | 800 | — | | |
| E _{ts} | Total Switching Loss | — | 4.33 | — | mJ | |
| L _E | Internal Emitter Inductance | — | 7.5 | — | nH | |
| C _{ies} | Input Capacitance | — | 550 | — | pF | V _{GE} = 0V V _{CC} = 30V f = 1.0MHz See Fig. 7 |
| C _{oes} | Output Capacitance | — | 39 | — | | |
| C _{res} | Reverse Transfer Capacitance | — | 7.1 | — | | |
| t _{rr} | Diode Reverse Recovery Time | — | 37 | 55 | ns | T _J = 25°C See Fig. 14 T _J = 125°C |
| | | — | 55 | 90 | | |
| I _{rr} | Diode Peak Reverse Recovery Current | — | 3.5 | 5.0 | A | T _J = 25°C See Fig. 15 T _J = 125°C |
| | | — | 4.5 | 8.0 | | |
| Q _{rr} | Diode Reverse Recovery Charge | — | 65 | 138 | nC | T _J = 25°C See Fig. 16 T _J = 125°C |
| | | — | 124 | 360 | | |
| di _(rec) M/dt | Diode Peak Rate of Fall of Recovery During t _b | — | 240 | — | A/μs | T _J = 25°C See Fig. 17 T _J = 125°C |
| | | — | 210 | — | | |

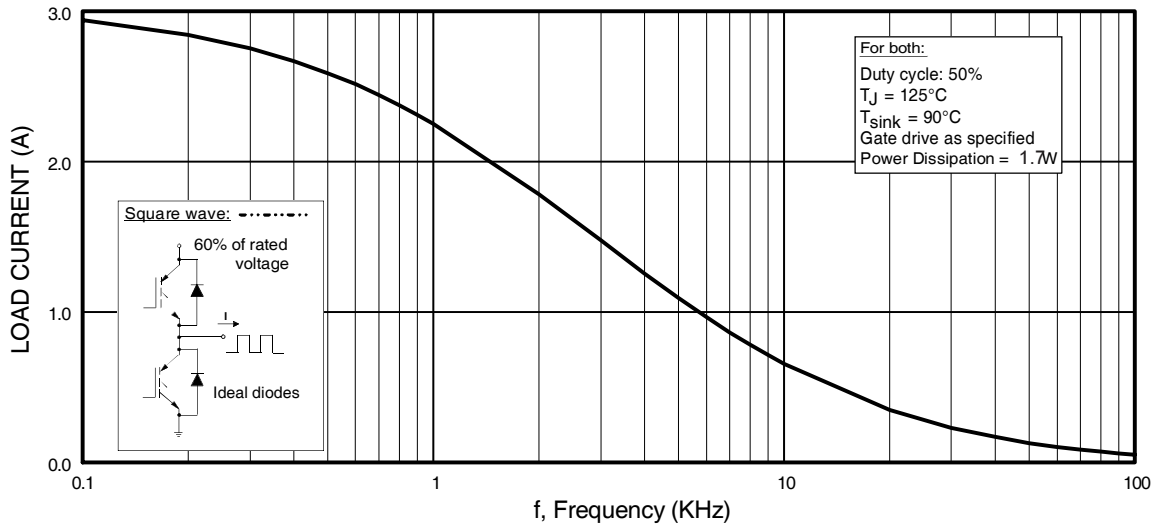


Fig. 1 - Typical Load Current vs. Frequency
(Load Current = I_{RMS} of fundamental)

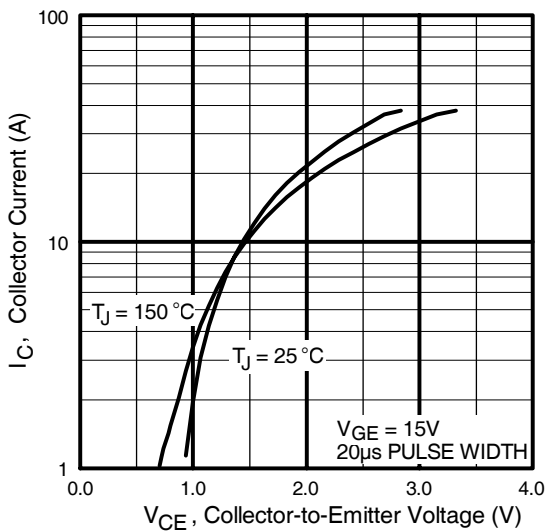


Fig. 2 - Typical Output Characteristics
www.irf.com

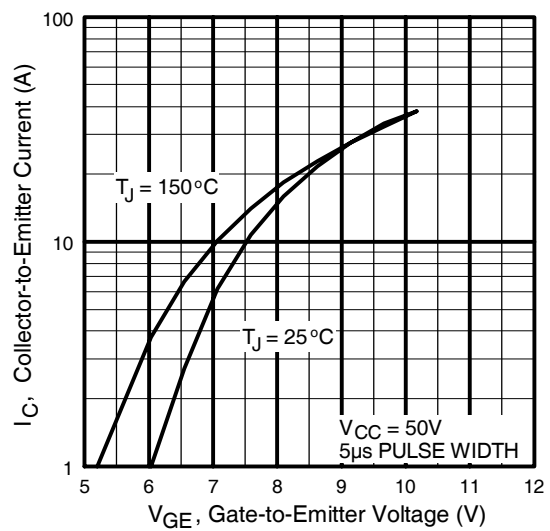


Fig. 3 - Typical Transfer Characteristics

IRG4BC20SD-SPbF

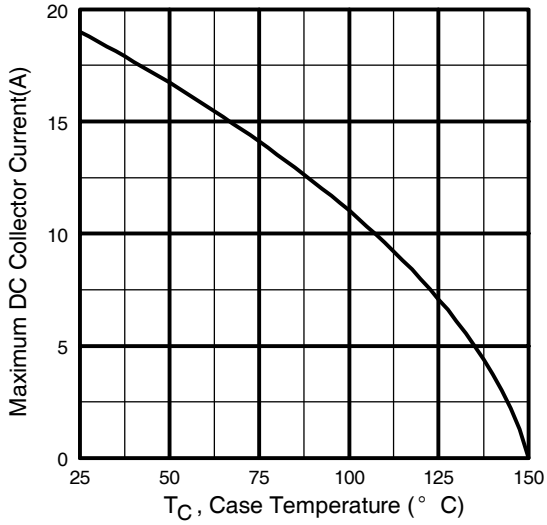


Fig. 4 - Maximum Collector Current vs. Case Temperature

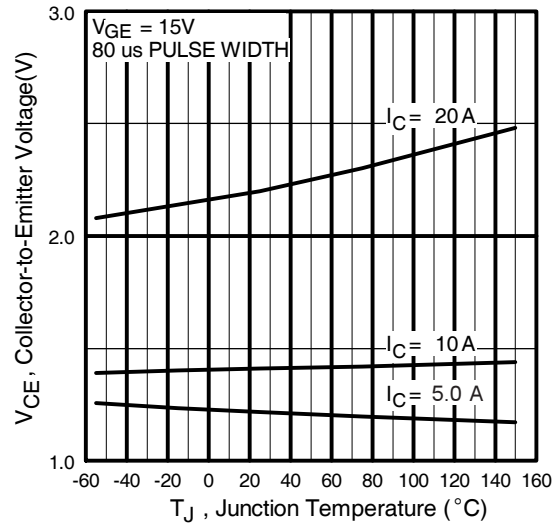


Fig. 5 - Typical Collector-to-Emitter Voltage vs. Junction Temperature

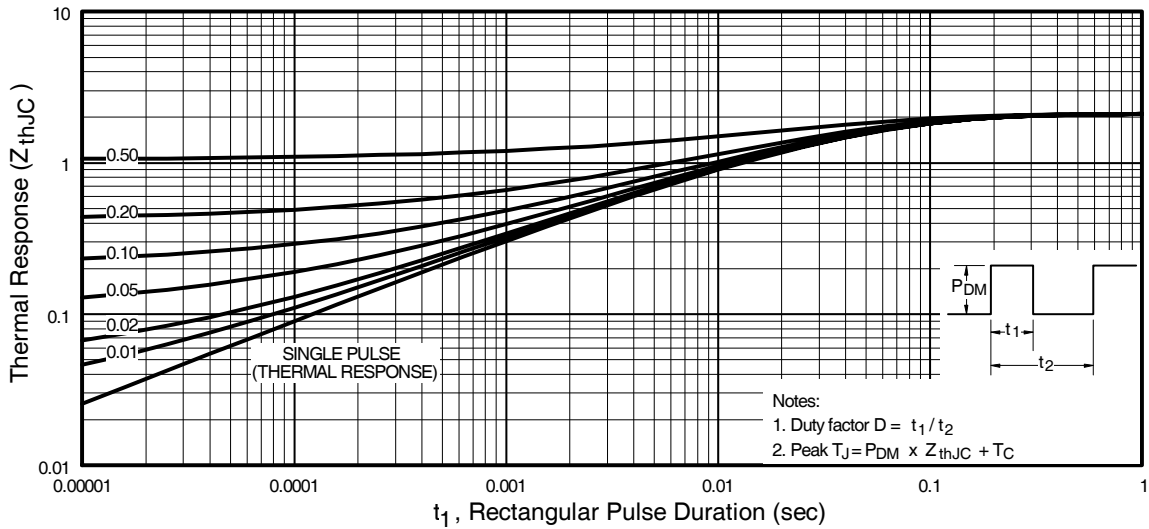


Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

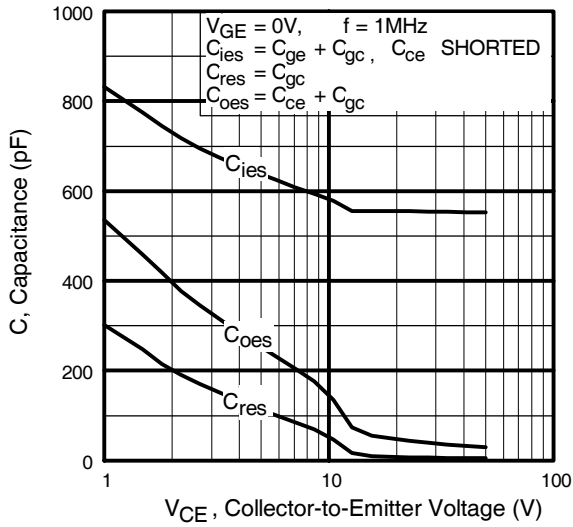


Fig. 7 - Typical Capacitance vs. Collector-to-Emitter Voltage

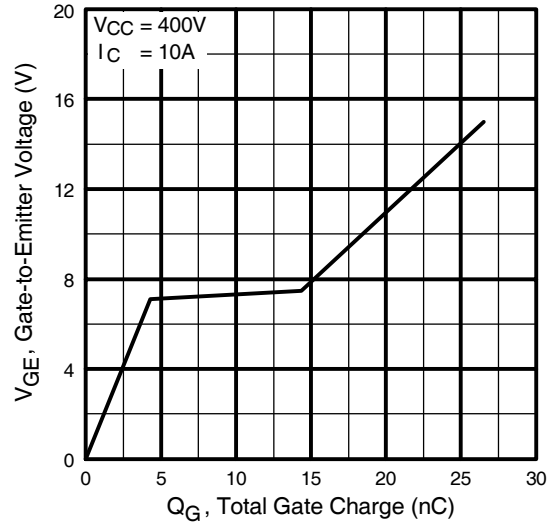


Fig. 8 - Typical Gate Charge vs. Gate-to-Emitter Voltage

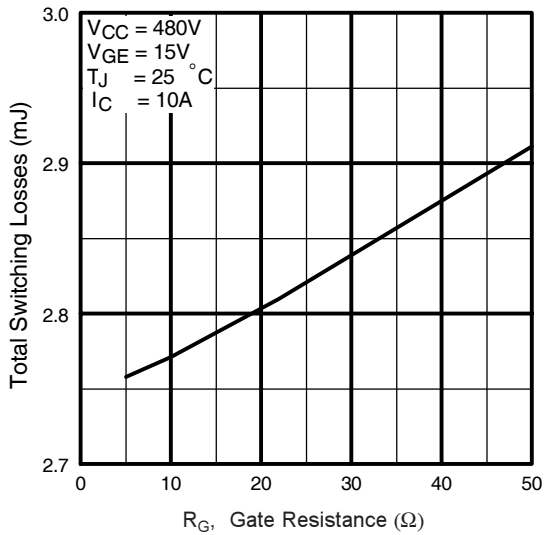


Fig. 9 - Typical Switching Losses vs. Gate Resistance

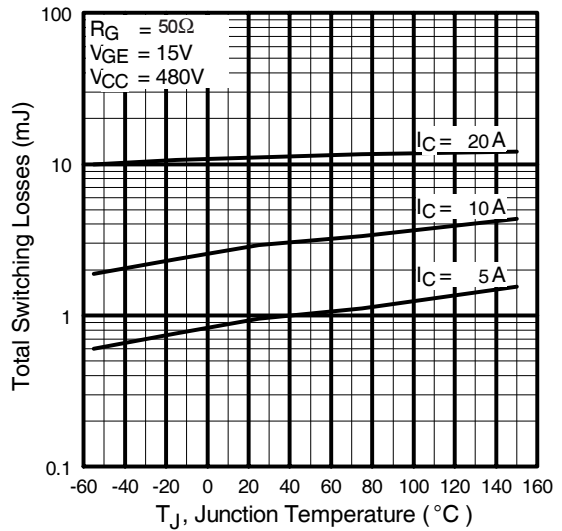


Fig. 10 - Typical Switching Losses vs. Junction Temperature

IRG4BC20SD-SPbF

International
IR Rectifier

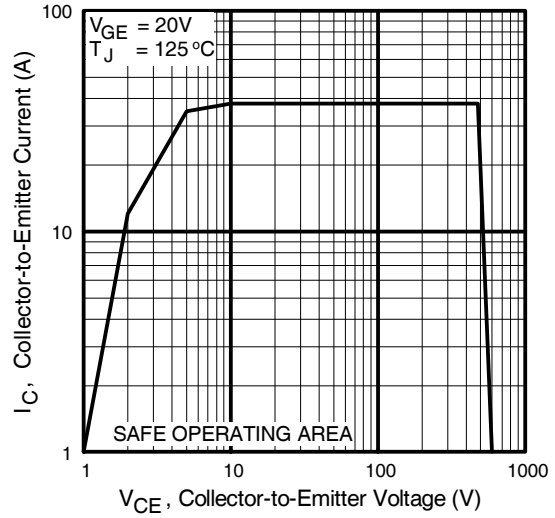
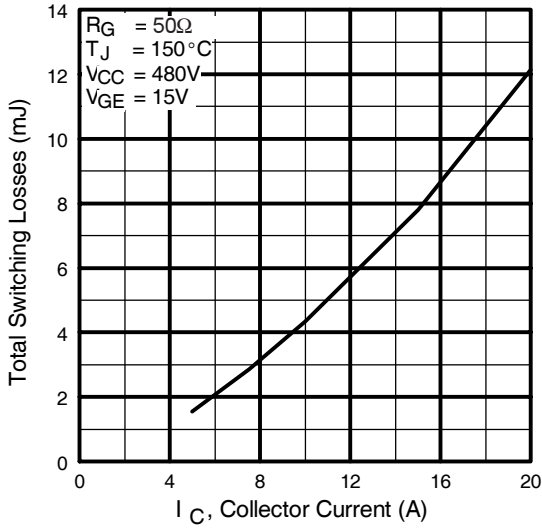


Fig. 11 - Typical Switching Losses vs. Collector-to-Emitter Current

Fig. 12 - Turn-Off SOA

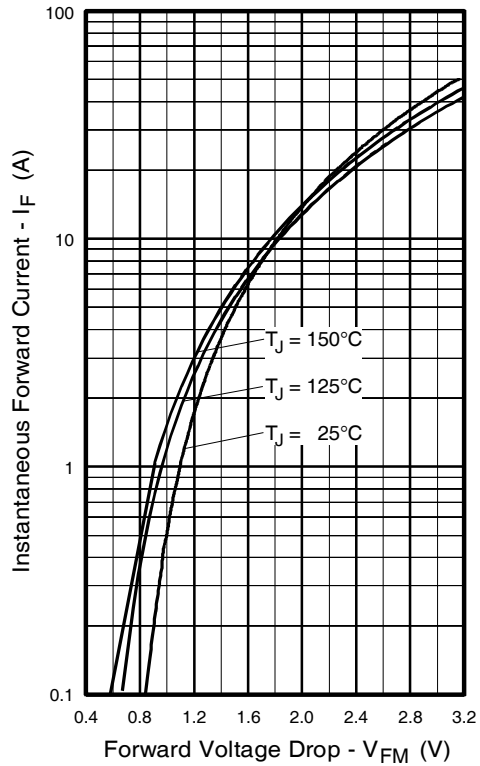


Fig. 13 - Maximum Forward Voltage Drop vs. Instantaneous Forward Current

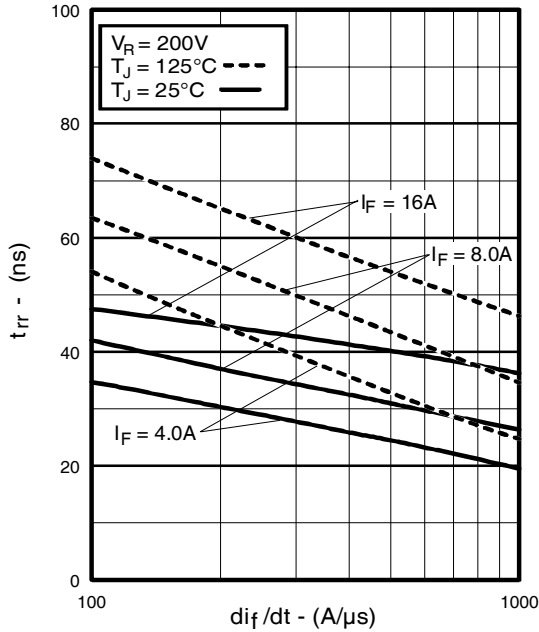


Fig. 14 - Typical Reverse Recovery vs. di_f/dt

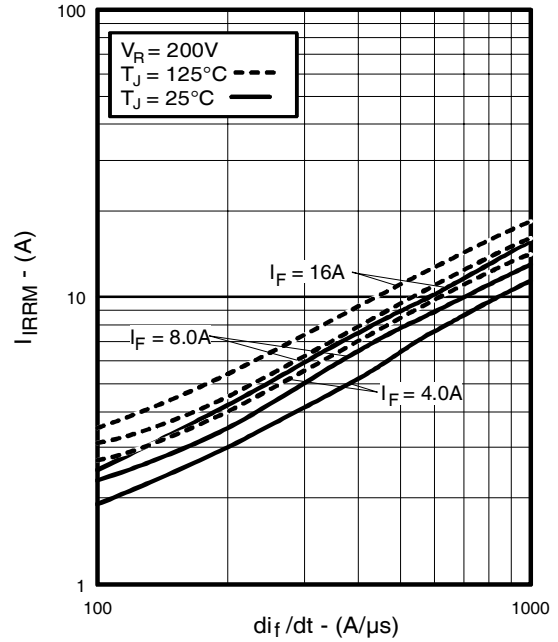


Fig. 15 - Typical Recovery Current vs. di_f/dt

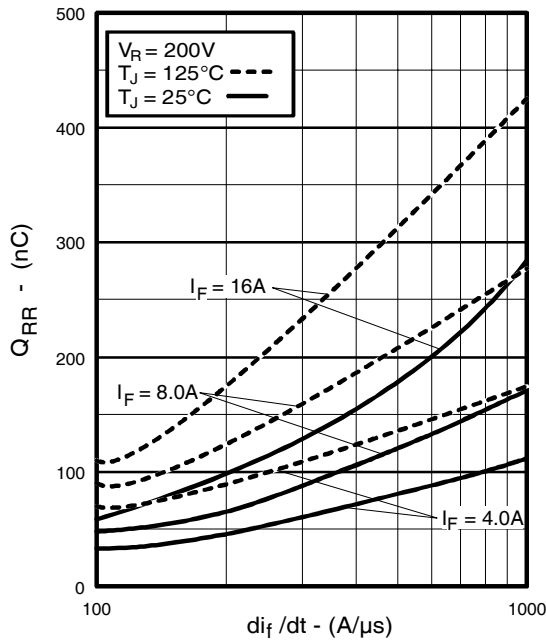


Fig. 16 - Typical Stored Charge vs. di_f/dt
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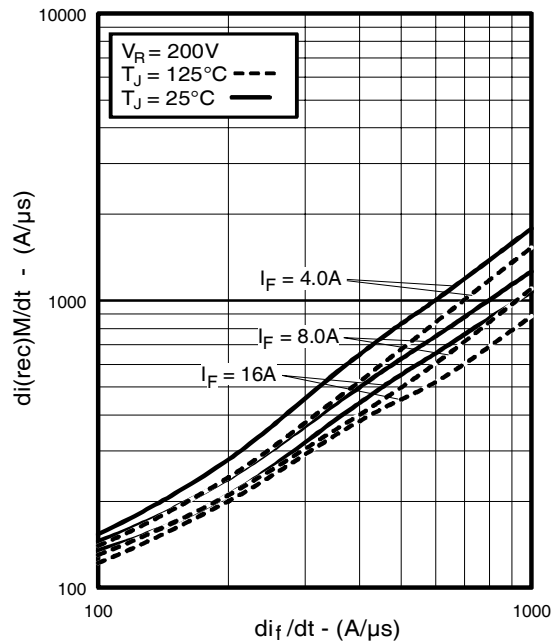


Fig. 17 - Typical $di_{(rec)M}/dt$ vs. di_f/dt

IRG4BC20SD-SPbF

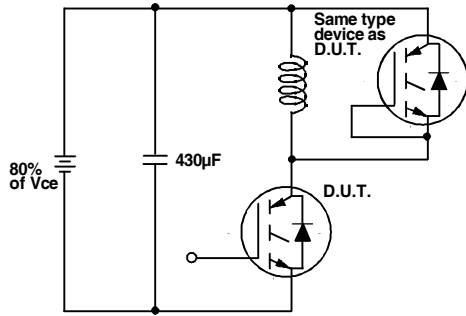


Fig. 18a - Test Circuit for Measurement of I_{LM} , E_{on} , $E_{off}(\text{diode})$, t_{rr} , Q_{rr} , I_{rr} , $t_{d(on)}$, t_r , $t_{d(off)}$, t_f

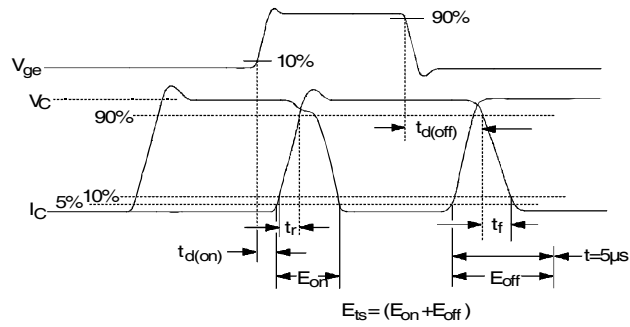


Fig. 18b - Test Waveforms for Circuit of Fig. 18a, Defining E_{off} , $t_{d(off)}$, t_f

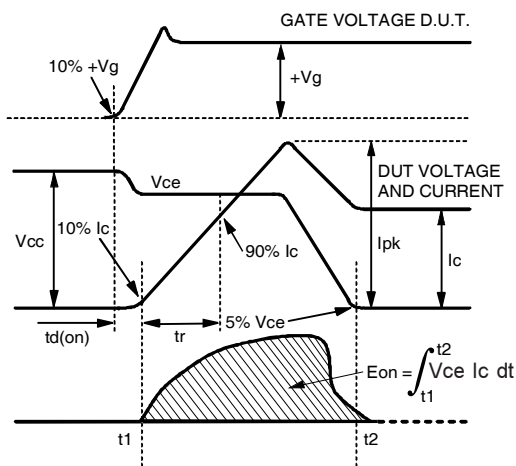


Fig. 18c - Test Waveforms for Circuit of Fig. 18a, Defining E_{on} , $t_{d(on)}$, t_r

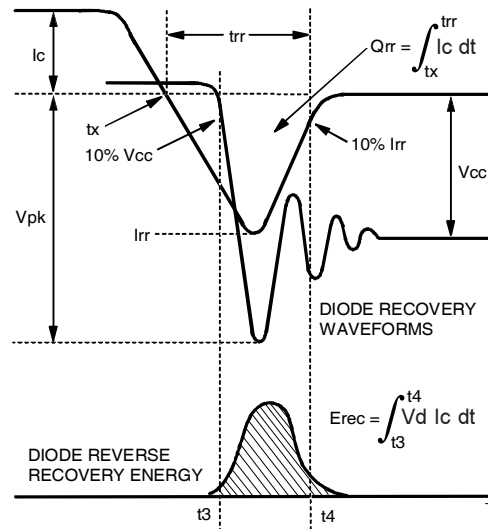


Fig. 18d - Test Waveforms for Circuit of Fig. 18a, Defining E_{rec} , t_{rr} , Q_{rr} , I_{rr}

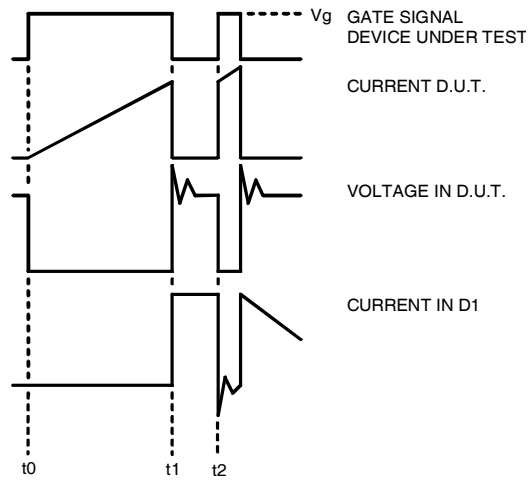


Figure 18e. Macro Waveforms for Figure 18a's Test Circuit

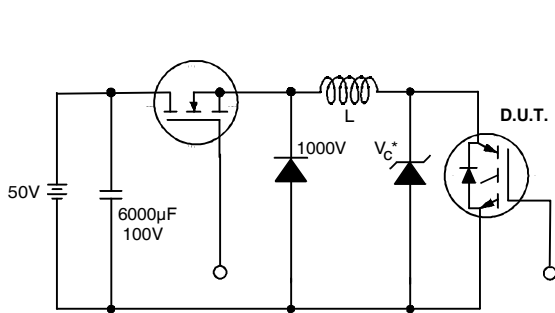


Figure 19. Clamped Inductive Load Test Circuit

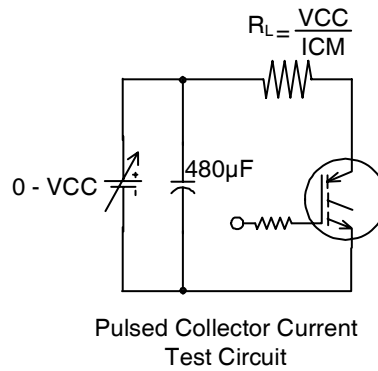


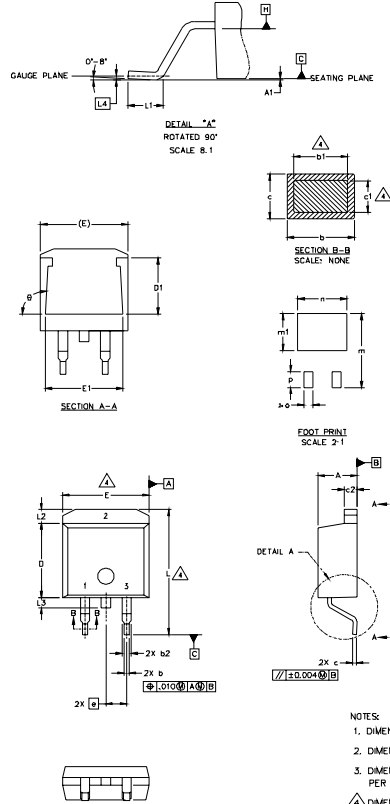
Figure 20. Pulsed Collector Current Test Circuit

IRG4BC20SD-SPbF



D²Pak Package Outline

Dimensions are shown in millimeters (inches)



| SYMBOL | DIMENSIONS | | | | NOTES |
|--------|-------------|-------|----------|------|-------|
| | MILLIMETERS | | INCHES | | |
| | MIN. | MAX. | MIN. | MAX. | |
| A | 4.06 | 4.83 | .160 | .190 | |
| A1 | 0.51 | 0.127 | | .005 | |
| b | 0.51 | 0.99 | .020 | .039 | 4 |
| b1 | 0.51 | 0.89 | .020 | .035 | |
| b2 | 1.14 | 1.40 | .045 | .055 | 4 |
| c | 0.43 | 0.63 | .017 | .025 | |
| c1 | 0.38 | 0.74 | .015 | .029 | 4 |
| c2 | 1.14 | 1.40 | .045 | .055 | |
| D | 8.51 | 9.65 | .335 | .380 | 3 |
| D1 | 5.33 | | .210 | | 3 |
| E | 9.65 | 10.67 | .380 | .420 | |
| E1 | 6.22 | | .245 | | 3 |
| e | 2.54 BSC | | .100 BSC | | |
| L | 14.61 | 15.88 | .575 | .625 | 3 |
| L1 | 1.78 | 2.79 | .070 | .110 | |
| L2 | | 1.65 | | .065 | 3 |
| L3 | 1.27 | 1.78 | .050 | .070 | |
| L4 | 0.25 BSC | | .010 BSC | | 3 |
| m | 17.78 | | .700 | | |
| m1 | 8.89 | | .350 | | 3 |
| n | 11.43 | | .450 | | |
| o | 2.08 | | .082 | | 3 |
| p | 3.81 | | .150 | | |
| θ | 90° | 93° | 90° | 93° | |

LEAD ASSIGNMENTS

| HEXFET | IGBTs, CoPACK | DIODES |
|-----------|---------------|------------|
| 1- GATE | 1- GATE | 1- ANODE * |
| 2- DRAIN | 2- COLLECTOR | 2- CATHODE |
| 3- SOURCE | 3- EMITTER | 3- ANODE |

* PART DEPENDENT.

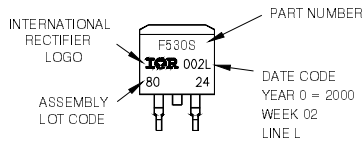
NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
4. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
5. CONTROLLING DIMENSION: INCH.

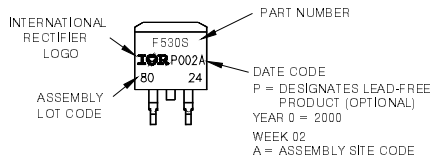
D²Pak Part Marking Information

EXAMPLE: THIS IS AN IRF530S WITH LOT CODE 8024 ASSEMBLED ON WW 02, 2000 IN THE ASSEMBLY LINE 'L'

Note: 'P' in assembly line position indicates 'Lead-Free'



OR



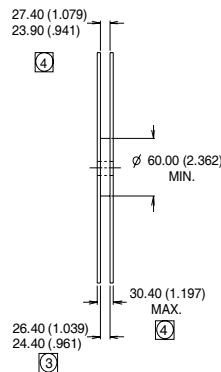
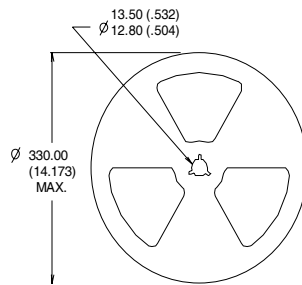
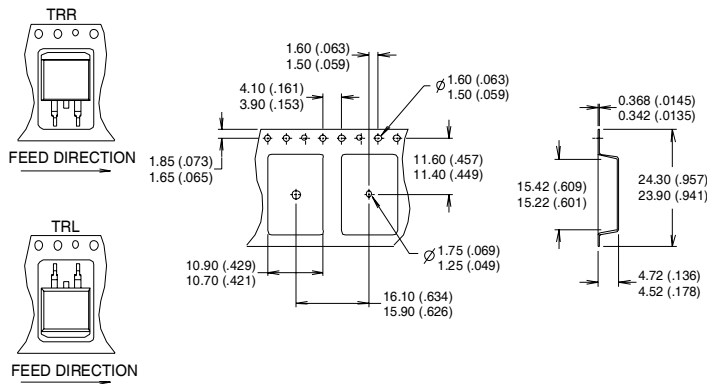
Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Notes:

- ① Repetitive rating: $V_{GE}=20V$; pulse width limited by maximum junction temperature (figure 20)
- ② $V_{CC}=80\%(V_{CES})$, $V_{GE}=20V$, $L=10\mu H$, $R_G = 50\Omega$ (figure 19)
- ③ Pulse width $\leq 80\mu s$; duty factor $\leq 0.1\%$.
- ④ Pulse width $5.0\mu s$, single shot.

D²Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)



- NOTES:
1. CONFORMS TO EIA-418.
 2. CONTROLLING DIMENSION: MILLIMETER.
 - ③ DIMENSION MEASURED @ HUB.
 - ④ INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Data and specifications subject to change without notice.